

## NCE P-Channel Enhancement Mode Power MOSFET

### Description

The NCE15P25J uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

### General Features

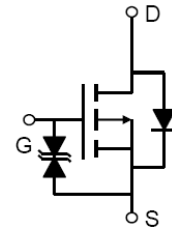
- $V_{DS} = -150V, I_D = -25A$   
 $R_{DS(ON)} < 135m\Omega @ V_{GS} = -10V$  (Typ. = 120mR)  
 $R_{DS(ON)} < 160m\Omega @ V_{GS} = -10V$  (Typ. = 131mR)
- Super high dense cell design
- Advanced trench process technology
- Reliable and rugged
- High density cell design for ultra low On-Resistance

### Application

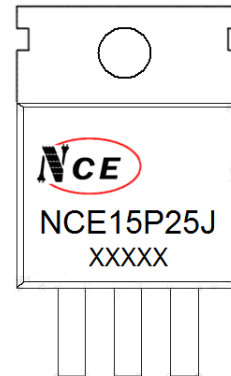
- Portable equipment and battery powered systems

**100% UIS TESTED!**

**100%  $\Delta V_{ds}$  TESTED!**



Schematic diagram



Marking and pin assignment



TO-220-3L top view

### Package Marking and Ordering Information

| Device Marking | Device    | Device Package | Reel Size | Tape width | Quantity |
|----------------|-----------|----------------|-----------|------------|----------|
| NCE15P25J      | NCE15P25J | TO-220-3L      |           |            |          |

### Absolute Maximum Ratings ( $T_C = 25^\circ C$ unless otherwise noted)

| Parameter                                        | Symbol             | Limit      | Unit          |
|--------------------------------------------------|--------------------|------------|---------------|
| Drain-Source Voltage                             | $V_{DS}$           | -150       | V             |
| Gate-Source Voltage                              | $V_{GS}$           | $\pm 20$   | V             |
| Drain Current-Continuous                         | $I_D$              | -25        | A             |
| Drain Current-Continuous( $T_C = 100^\circ C$ )  | $I_D(100^\circ C)$ | -17        | A             |
| Pulsed Drain Current                             | $I_{DM}$           | -140       | A             |
| Maximum Power Dissipation                        | $P_D$              | 160        | W             |
| Derating factor                                  |                    | 1.3        | W/ $^\circ C$ |
| Operating Junction and Storage Temperature Range | $T_J, T_{STG}$     | -55 To 150 | $^\circ C$    |

## Thermal Characteristic

|                                                          |                 |     |                      |
|----------------------------------------------------------|-----------------|-----|----------------------|
| Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup> | $R_{\theta jc}$ | 0.8 | $^{\circ}\text{C/W}$ |
|----------------------------------------------------------|-----------------|-----|----------------------|

## Electrical Characteristics ( $T_c=25^{\circ}\text{C}$ unless otherwise noted)

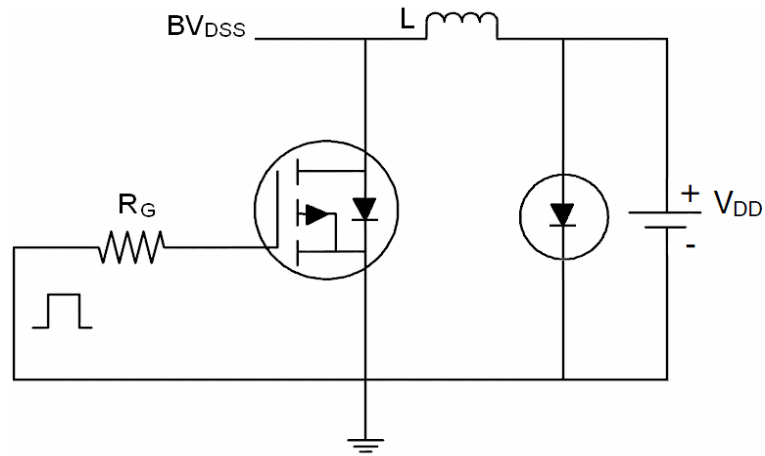
| Parameter                          | Symbol              | Condition                                                                                    | Min  | Typ  | Max  | Unit |
|------------------------------------|---------------------|----------------------------------------------------------------------------------------------|------|------|------|------|
| Off Characteristics                |                     |                                                                                              |      |      |      |      |
| Drain-Source Breakdown Voltage     | BV <sub>DSS</sub>   | V <sub>GS</sub> =0V I <sub>D</sub> =-250μA                                                   | -145 | -155 | -    | V    |
| Zero Gate Voltage Drain Current    | I <sub>DSS</sub>    | V <sub>DS</sub> =-145V, V <sub>GS</sub> =0V                                                  | -    | -    | 1    | μA   |
| Gate-Body Leakage Current          | I <sub>GSS</sub>    | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                                                   | -    | -    | ±100 | nA   |
| On Characteristics (Note 3)        |                     |                                                                                              |      |      |      |      |
| Gate Threshold Voltage             | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                    | -1.5 | -1.9 | -3   | V    |
| Drain-Source On-State Resistance   | R <sub>DS(ON)</sub> | V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A                                                  | -    | 120  | 135  | mΩ   |
|                                    |                     | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A                                                 | -    | 131  | 160  |      |
| Forward Transconductance           | g <sub>FS</sub>     | V <sub>DS</sub> =-5V, I <sub>D</sub> =-20A                                                   | 5    | -    | -    | S    |
| Dynamic Characteristics (Note4)    |                     |                                                                                              |      |      |      |      |
| Input Capacitance                  | C <sub>ISS</sub>    | V <sub>DS</sub> =-75V, V <sub>GS</sub> =0V,<br>F=1.0MHz                                      | -    | 7650 | -    | pF   |
| Output Capacitance                 | C <sub>OSS</sub>    |                                                                                              | -    | 148  | -    | pF   |
| Reverse Transfer Capacitance       | C <sub>RSS</sub>    |                                                                                              | -    | 131  | -    | pF   |
| Switching Characteristics (Note 4) |                     |                                                                                              |      |      |      |      |
| Turn-on Delay Time                 | t <sub>d(on)</sub>  | V <sub>DD</sub> =-75V, I <sub>D</sub> =-20A<br>V <sub>GS</sub> =-10V, R <sub>GEN</sub> =9.1Ω | -    | 17   | -    | nS   |
| Turn-on Rise Time                  | t <sub>r</sub>      |                                                                                              | -    | 80   | -    | nS   |
| Turn-Off Delay Time                | t <sub>d(off)</sub> |                                                                                              | -    | 45   | -    | nS   |
| Turn-Off Fall Time                 | t <sub>f</sub>      |                                                                                              | -    | 65   | -    | nS   |
| Total Gate Charge                  | Q <sub>g</sub>      | V <sub>DS</sub> =-75V, I <sub>D</sub> =-20A,<br>V <sub>GS</sub> =-10V                        | -    | 137  | -    | nC   |
| Gate-Source Charge                 | Q <sub>gs</sub>     |                                                                                              | -    | 25   | -    | nC   |
| Gate-Drain Charge                  | Q <sub>gd</sub>     |                                                                                              | -    | 28   | -    | nC   |
| Drain-Source Diode Characteristics |                     |                                                                                              |      |      |      |      |
| Diode Forward Voltage (Note 3)     | V <sub>SD</sub>     | V <sub>GS</sub> =0V, I <sub>S</sub> =-25A                                                    | -    | -    | -1.2 | V    |
| Diode Forward Current (Note 2)     | I <sub>S</sub>      | -                                                                                            | -    | -    | -25  | A    |
| Reverse Recovery Time              | t <sub>rr</sub>     | TJ = 25°C, IF =-25A                                                                          | -    | 90   | -    | nS   |
| Reverse Recovery Charge            | Q <sub>rr</sub>     | di/dt = 100A/μs (Note3)                                                                      | -    | 105  | -    | nC   |

## Notes:

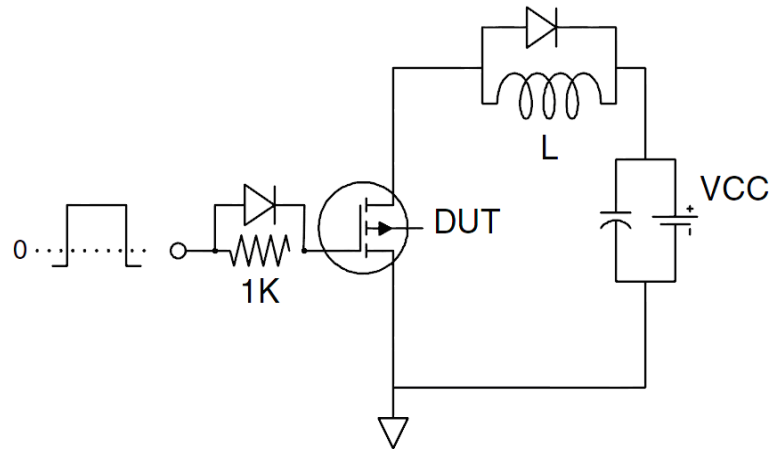
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board,  $t \leq 10$  sec.
3. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production
5. EAS condition:  $T_J=25^{\circ}\text{C}, V_{DD}=-50V, V_G=-10V, L=0.5mH, R_g=25\Omega$

## Test Circuit

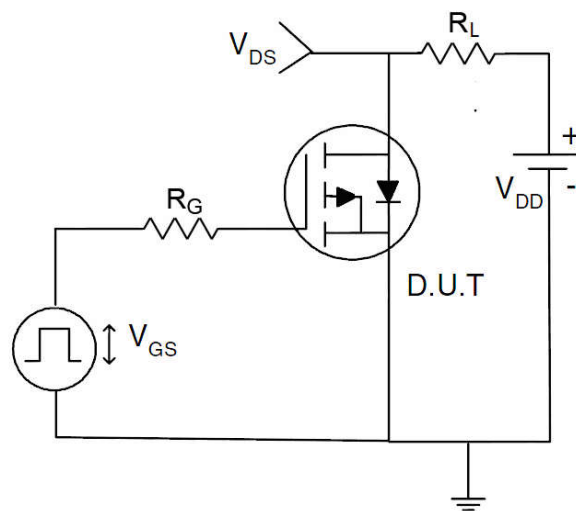
### 1) $E_{AS}$ Test Circuit



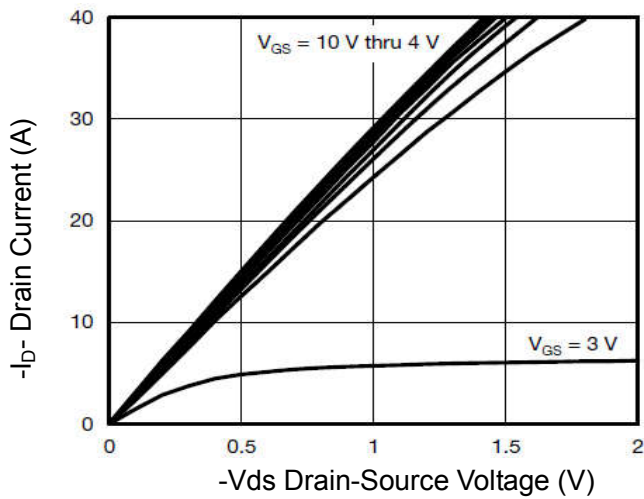
### 2) Gate Charge Test Circuit



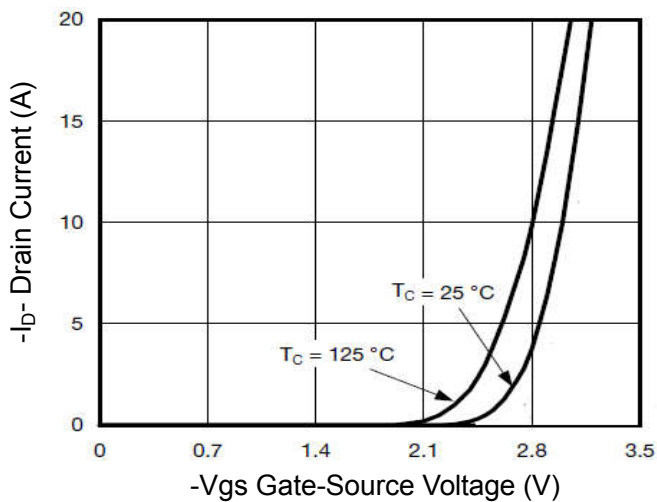
### 3) Switch Time Test Circuit



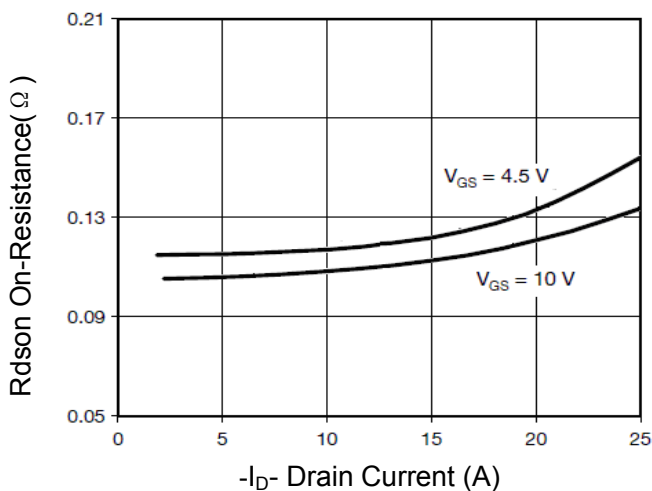
## Typical Electrical and Thermal Characteristics (Curves)



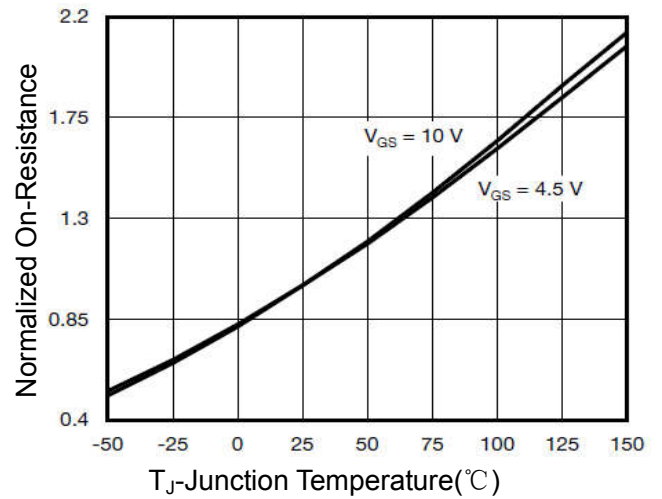
**Figure 1 Output Characteristics**



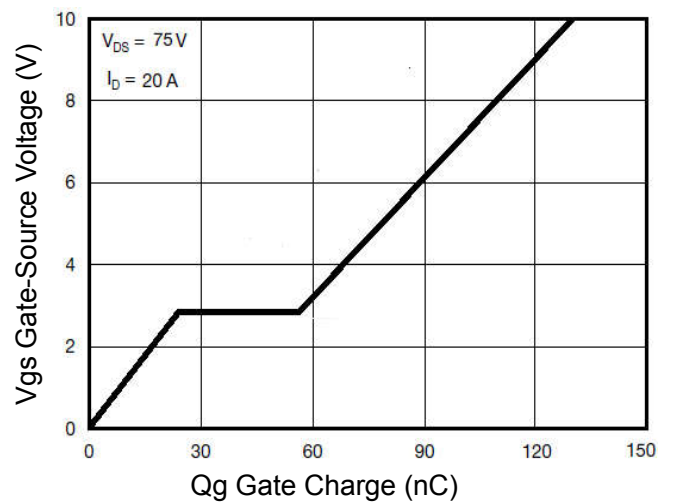
**Figure 2 Transfer Characteristics**



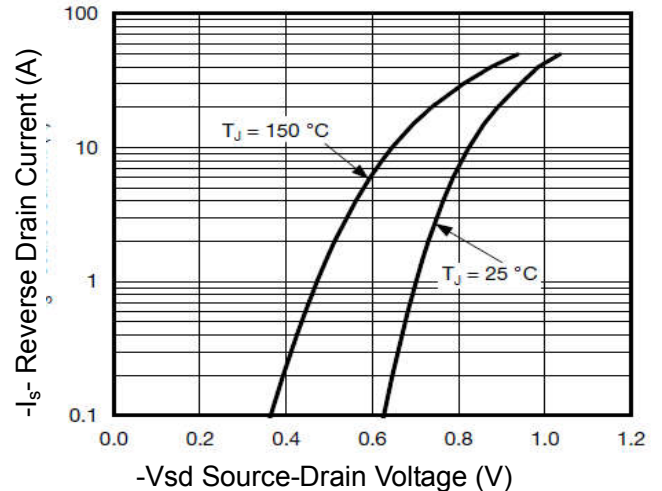
**Figure 3 Rdson- Drain Current**



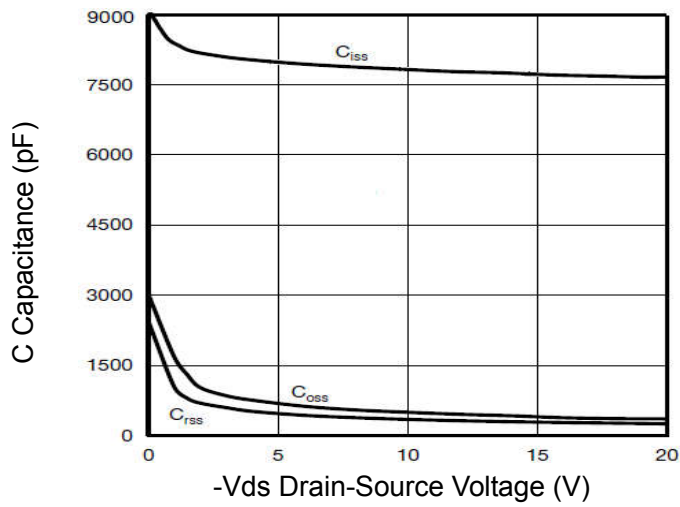
**Figure 4 Rdson-Junction Temperature**



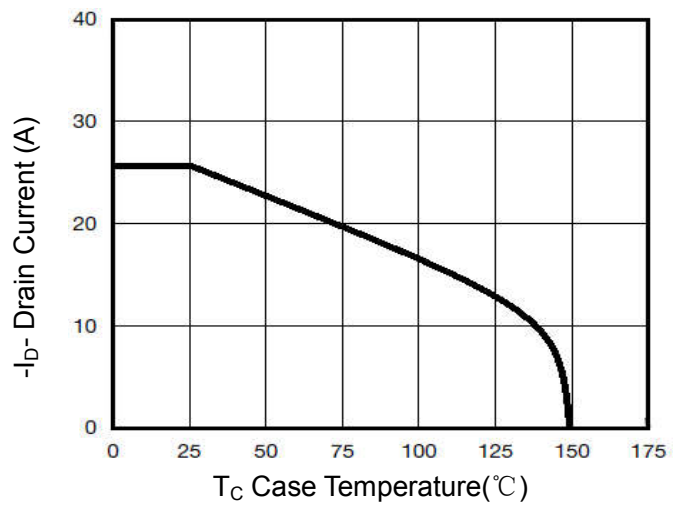
**Figure 5 Gate Charge**



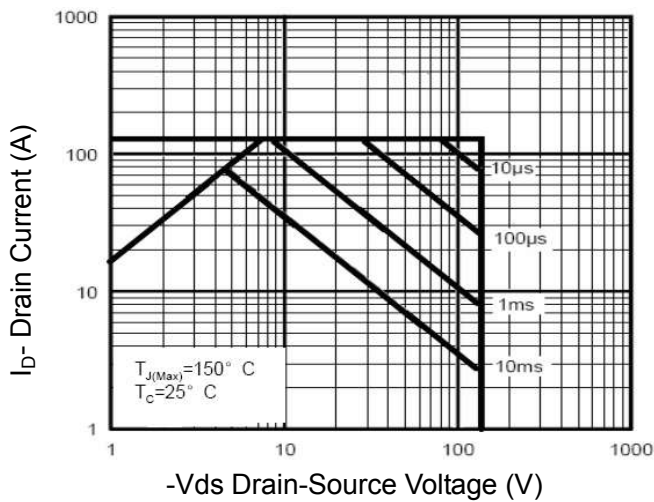
**Figure 6 Source- Drain Diode Forward**



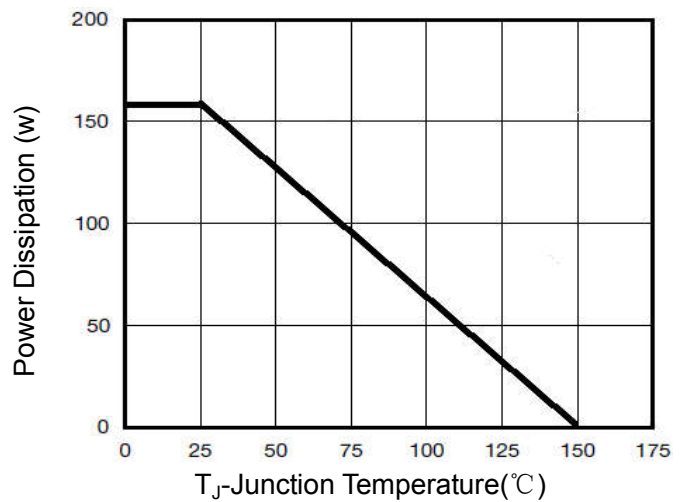
**Figure 7 Capacitance vs Vds**



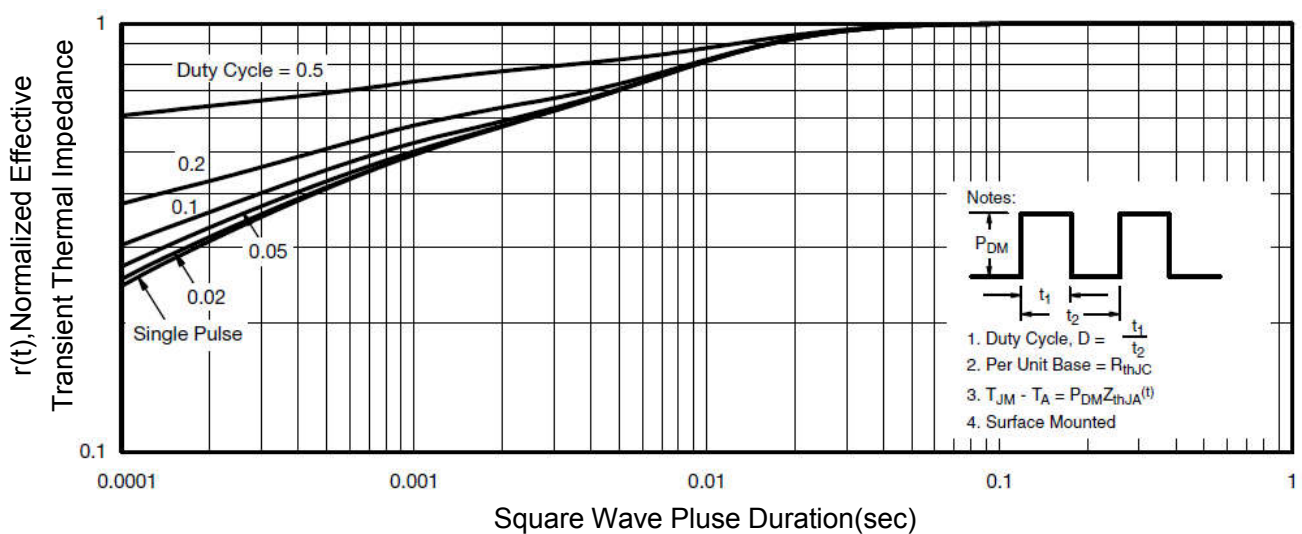
**Figure 9 Drain Current vs Case Temperature**



**Figure 8 Safe Operation Area**

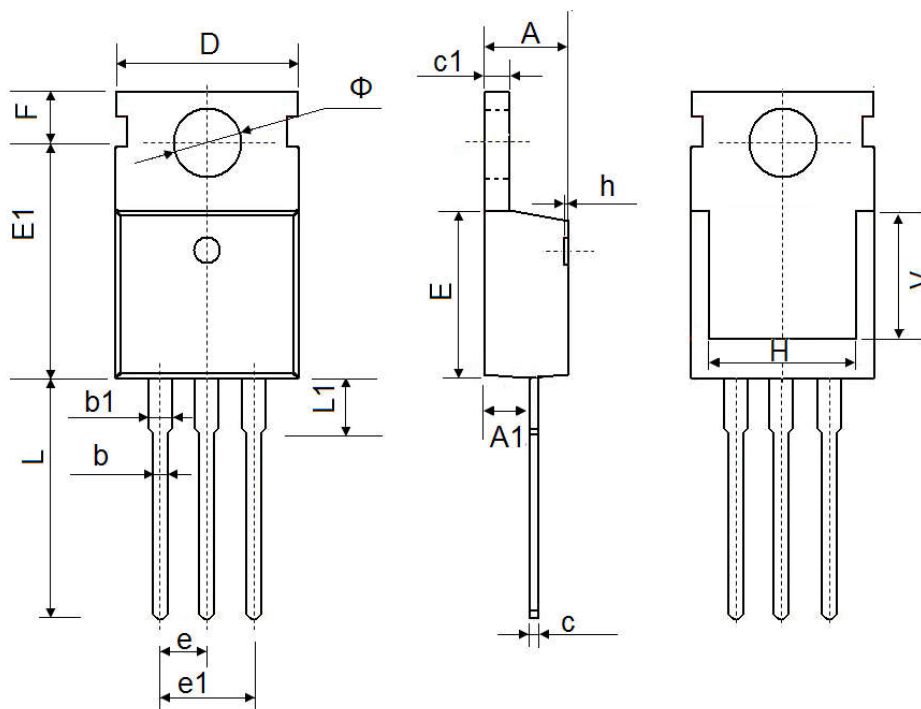


**Figure 10 Power De-rating**



**Figure 11 Normalized Maximum Transient Thermal Impedance**

## TO-220-3L Package Information



| Symbol | Dimensions In Millimeters |        | Dimensions In Inches |       |
|--------|---------------------------|--------|----------------------|-------|
|        | Min.                      | Max.   | Min.                 | Max.  |
| A      | 4.400                     | 4.600  | 0.173                | 0.181 |
| A1     | 2.250                     | 2.550  | 0.089                | 0.100 |
| b      | 0.710                     | 0.910  | 0.028                | 0.036 |
| b1     | 1.170                     | 1.370  | 0.046                | 0.054 |
| c      | 0.330                     | 0.650  | 0.013                | 0.026 |
| c1     | 1.200                     | 1.400  | 0.047                | 0.055 |
| D      | 9.910                     | 10.250 | 0.390                | 0.404 |
| E      | 8.9500                    | 9.750  | 0.352                | 0.384 |
| E1     | 12.650                    | 12.950 | 0.498                | 0.510 |
| e      | 2.540 TYP.                |        | 0.100 TYP.           |       |
| e1     | 4.980                     | 5.180  | 0.196                | 0.204 |
| F      | 2.650                     | 2.950  | 0.104                | 0.116 |
| H      | 7.900                     | 8.100  | 0.311                | 0.319 |
| h      | 0.000                     | 0.300  | 0.000                | 0.012 |
| L      | 12.900                    | 13.400 | 0.508                | 0.528 |
| L1     | 2.850                     | 3.250  | 0.112                | 0.128 |
| V      | 7.500 REF.                |        | 0.295 REF.           |       |
| Φ      | 3.400                     | 3.800  | 0.134                | 0.150 |

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